Lecture 4 Generative Models for Discrete Data - Part 3

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Naive Bayes Classifiers

- Basic Concepts
- Class-Conditional Distributions
- Likelihood
- MLE
- Bayesian Naive Bayes
- Prior
- Posterior
- MAP
- Posterior Predictive
- Plug-in Approximation
- Log-Sum-Exp Trick
- Posterior Predictive Algorithm
- Feature Selection

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Generative Classifiers vs Discriminative Classifiers

probabilistic classifier

- we are given a dataset $\mathcal{D} = \{(\mathbf{x}_i, y_i)\}_{i=1}^N$
- the goal is to compute the class posterior p(y = c | x) which models the mapping y = f(x)

generative classifiers

• p(y = c | x) is computed starting from the class-conditional density $p(x|y = c, \theta)$ and the class prior $p(y = c | \theta)$ given that

$$p(y = c | \mathbf{x}, \theta) \propto p(\mathbf{x} | y = c, \theta) p(y = c | \theta)$$
 $(= p(y = c, \mathbf{x} | \theta))$

- this is called a generative classifier since it specifies how to generate the feature vector x for each class y = c (by using p(x|y = c, θ))
- the model is usually fit by maximizing the joint log-likelihood, i.e. one computes $\theta^* = \arg \max_{\theta} \sum_i \log p(y_i, \mathbf{x}_i | \theta)$

discriminative classifiers

- the model p(y = c | x) is directly fit to the data
- the model is usually fit by maximizing the conditional log-likelihood, i.e. one computes θ^{*} = arg max_θ ∑_i log p(y_i|x_i, θ)

Naive Bayes Classifiers Basic Concepts

- a Naive Bayes Classifier (NBC) uses a generative approach
 - let $\mathbf{x} = [x_1, ..., x_D]^T$ be our feature vector with D components¹
 - let $y \in \{1, ..., C\}$ where C is the number of classes
 - assumption: the *D* features are assumed to be conditionally independent given the class label, i.e.

$$p(\mathbf{x}|y=c, \boldsymbol{\theta}) = \prod_{j=1}^{D} p(x_j|y=c, \theta_{jc})$$

- this is the simplest approach to specify a class-conditional density
- it is called "naive" since we do not actually expect the features to be conditionally independent, even conditional to the class label y = c
- even if the naive assumption is not true, NBC often works well given that the model is quite simple and depends on O(CD) parameters and hence is relatively immune to overfitting

 ${}^{1}\text{one can have } \textbf{\textit{x}} \in \mathbb{R}^{D} \text{ or } \textbf{\textit{x}} \in \{1,2,...,K\}^{D} \text{ or } \textbf{\textit{x}} \in \{0,1\}^{D} \text{ or }$

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the form of the class-conditional density depends on the type of each feature

• if $x_j \in \mathbb{R}$ we can use the Gaussian distribution

$$p(\mathbf{x}|y=c,\boldsymbol{\theta}) = \prod_{j=1}^{D} \mathcal{N}(x_j|\mu_{jc},\sigma_{jc}^2)$$

where for each class c we specify the mean μ_{jc} of feature j and its variance σ_{jc}

• if $x_j \in \{0,1\}$ we can use the Bernoulli distribution

$$p(\mathbf{x}|y = c, \boldsymbol{\theta}) = \prod_{j=1}^{D} Ber(x_j|\mu_{jc})$$

where for each class c we specify the probability $\mu_{jc} = p(x_j = 1 | y = c)$, i.e. the probability that feature j occurs

Class-Conditional Distributions

• if $x_j \in \{1, ..., K\}$ we can use the categorical distribution

$$p(\mathbf{x}|y=c, \mathbf{ heta}) = \prod_{j=1}^{D} Cat(x_j|\mu_{jc})$$

where for each class c we specify the histogram

$$\mu_{jc} = [p(x_j = 1 | y = c), ..., p(x_j = K | y = c)]$$

• other kind of features can be conceived and we can mix different kind of features

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Naive Bayes Classifiers Likelihood

probability for single data case

$$p(\mathbf{x}_i, y_i | \boldsymbol{\theta}) = p(y_i | \boldsymbol{\pi}) p(\mathbf{x}_i | y_i, \boldsymbol{\theta}) = (\text{NBC assumption}) = p(y_i | \boldsymbol{\pi}) \prod_j p(x_{ij} | y_i, \boldsymbol{\theta}_j)$$

where $oldsymbol{ heta}$ is a compound vector parameter containing $oldsymbol{\pi}$ and $oldsymbol{ heta}_j$

• since $y_i \sim \operatorname{Cat}(\pi)$

$$p(y_i|\boldsymbol{\pi}) = \prod_c \pi_c^{\mathbb{I}(y_i=c)}$$

• for each class c we allocate a specific set of parameters θ_{jc}

$$p(x_{ij}|y_i, \theta_j) = \prod_c p(x_{ij}|\theta_{jc})^{\mathbb{I}(y_i=c)}$$

hence

$$p(\mathbf{x}_i, y_i | \boldsymbol{\theta}) = \prod_c \pi_c^{\mathbb{I}(y_i = c)} \prod_j \prod_c p(x_{ij} | \boldsymbol{\theta}_{jc})^{\mathbb{I}(y_i = c)}$$

• the log-likelihood is given by

$$\log p(\mathcal{D}|\theta) = \sum_{i=1}^{N} \log p(\mathbf{x}_{i}, y_{i}|\theta) = \sum_{i=1}^{N} \sum_{c=1}^{C} \log \pi_{c}^{\mathbb{I}(y_{i}=c)} + \sum_{i=1}^{N} \sum_{j=1}^{D} \sum_{c=1}^{C} \log p(\mathbf{x}_{ij}|\theta_{jc})^{\mathbb{I}(y_{i}=c)}$$
$$= \sum_{c=1}^{C} N_{c} \log \pi_{c} + \sum_{j=1}^{D} \sum_{c=1}^{C} \sum_{i:y_{i}=c} \log p(\mathbf{x}_{ij}|\theta_{jc})$$

where $N_c \triangleq \sum_i \mathbb{I}(y_i = c)$ and we assumed as usual that the pairs (\mathbf{x}_i, y_i) are iid

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• the log-likelihood is

$$\log p(\mathcal{D}|\boldsymbol{\theta}) = \sum_{c=1}^{C} N_c \log \pi_c + \sum_{j=1}^{D} \sum_{c=1}^{C} \sum_{i:y_i=c} \log p(x_{ij}|\boldsymbol{\theta}_{jc})$$

here we have the sum of two terms, the first concerning $\pi = [\pi_1, ..., \pi_C]$ and the second concerning *DC* set of parameters θ_{jc}

• in order to compute the MLE we can optimize the two group of parameters π and θ_{jc} separately

• the log-likelihood is

$$\log p(\mathcal{D}|\boldsymbol{\theta}) = \sum_{c=1}^{C} N_c \log \pi_c + \sum_{j=1}^{D} \sum_{c=1}^{C} \sum_{i: y_i = c} \log p(x_{ij}|\boldsymbol{\theta}_{jc})$$

- the first term concerns the labels y_i ~ Cat(π), recall how we computed the MLE of the Dirichlet-multinomial model
- the MLE can be computed by optimizing the Lagrangian

$$I(\pi, \lambda) = \sum_{c} N_{c} \log \pi_{c} + \lambda \left(1 - \sum_{c} \pi_{c}\right)$$

where we enforce the constraint $\sum_c \pi_c = 1$

• we impose $\frac{\partial l}{\partial \pi_c} = 0$, $\frac{\partial l}{\partial \lambda} = 0$ and we obtain the MLE estimation

$$\hat{\pi}_c = \frac{N_c}{N}$$

• the log-likelihood is

$$\log p(\mathcal{D}|\boldsymbol{\theta}) = \sum_{c=1}^{C} N_c \log \pi_c + \sum_{j=1}^{D} \sum_{c=1}^{C} \sum_{i:y_j=c} \log p(x_{ij}|\boldsymbol{\theta}_{jc})$$

- as for the second term optimization, we assume the features x_{ij} are binary, i.e. $x_{ij} \in \{0, 1\}$, and $x_{ij}|y = c \sim \text{Ber}(\theta_{jc})$, hence $\theta_{jc} = \theta_{jc} \in [0, 1]$
- in this case, we could compute the MLE by using the analysis which was performed with the beta-binomial model
- doing the math again, we have to optimize the function

$$J = \sum_{j=1}^{D} \sum_{c=1}^{C} \sum_{i:y_i=c} \log p(x_{ij}|\theta_{jc}) = \sum_{j=1}^{D} \sum_{c=1}^{C} \sum_{i:y_i=c} \left(\mathbb{I}(x_{ij}=1) \log \theta_{jc} + \mathbb{I}(x_{ij}=0) \log(1-\theta_{jc}) \right)$$
$$= \sum_{j=1}^{D} \sum_{c=1}^{C} N_{jc} \log \theta_{jc} + \sum_{j=1}^{D} \sum_{c=1}^{C} (N_c - N_{jc}) \log(1-\theta_{jc})$$
where $N_{jc} \triangleq \sum_i \mathbb{I}(x_{ij}=1, y_i=c)$ and $N_c \triangleq \sum_i \mathbb{I}(y_i=c)$

• we have to optimize the function

$$J = \sum_{j=1}^{D} \sum_{c=1}^{C} N_{jc} \log \theta_{jc} + \sum_{j=1}^{D} \sum_{c=1}^{C} (N_c - N_{jc}) \log(1 - \theta_{jc})$$

where
$$N_{jc} \triangleq \sum_{i} \mathbb{I}(x_{ij} = 1, y_i = c)$$
 and $N_c \triangleq \sum_{i} \mathbb{I}(y_i = c)$
• by imposing $\frac{\partial J}{\partial \theta_{jc}} = 0$ one obtains the MLE estimate

$$\hat{\theta}_{jc} = \frac{N_{jc}}{N_c}$$

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Naive Bayes Classifiers Model Fitting

algorithm: MLE fitting a naive Bayes classifier to binary features (i.e. $x_i \in \{0, 1\}^D$)

$$\begin{array}{l} N_c = 0, \ N_{jc} = 0 \ ; \\ \text{for } i = 1 : N \ \text{do} \\ \\ \\ R_c := y_i; \ // \ \text{get the class label of the } i\text{-th sample} \\ \\ N_c := N_c + 1; \\ \text{for } j = 1 : D \ \text{do} \\ \\ \\ \\ | \ If \ x_{ij} = 1 \ \text{then} \\ \\ \\ | \ N_{jc} := N_{jc} + 1 \\ \\ \text{end} \\ \\ \\ \text{end} \end{array}$$

end

 $\hat{\pi}_{c} = rac{N_{c}}{N}$, $\hat{ heta}_{jc} = rac{N_{jc}}{N_{c}}$;

- see the *naiveBayesFit* script for some Matlab code
- the algorithm takes O(ND) time

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- as we know the MLE estimates can overfit
- recall the black swan paradox and the issue of using empirical fractions N_i/N
- a simple solution to overfitting is to be Bayesian

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• for simplicity we use a factored prior

$$p(\boldsymbol{ heta}) = p(\boldsymbol{\pi}) \prod_{j=1}^{D} \prod_{c=1}^{C} p(\theta_{jc})$$

where $\boldsymbol{\theta}$ is a compound vector parameter containing $\boldsymbol{\pi}, \theta_{jc}$

• as for the prior of π we use

$$p(\pi) = \mathsf{Dir}(\pi|lpha)$$

which is a conjugate prior w.r.t. the multinomial part

• as for the prior of each θ_{ic} we use

$$p(\theta_{jc}) = \mathsf{Beta}(\theta_{jc}|\beta_0,\beta_1)$$

which is a conjugate prior w.r.t. the binomial part

• we can obtain a uniform prior by setting $oldsymbol{lpha}=oldsymbol{1}$ and $eta_0=eta_1=oldsymbol{1}$

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The Beta-Binomial Model

Posterior

factored likelihood

$$\log p(\mathcal{D}|\boldsymbol{\theta}) = \log \operatorname{Cat}(y|\boldsymbol{\pi}) + \sum_{j=1}^{D} \sum_{c=1}^{C} \sum_{i:y_j=c} \log \operatorname{Ber}(x_{ij}|\theta_{jc})$$

factored prior

$$p(\boldsymbol{\theta}) = \mathsf{Dir}(\boldsymbol{\pi}|\boldsymbol{lpha}) \prod_{j=1}^{D} \prod_{c=1}^{C} \mathsf{Beta}(\theta_{jc}|\beta_0,\beta_1)$$

factored posterior

$$p(\boldsymbol{\theta}|\mathcal{D}) = p(\boldsymbol{\pi}|\mathcal{D}) \prod_{j=1}^{D} \prod_{c=1}^{C} p(\theta_{jc}|\mathcal{D})$$
$$p(\boldsymbol{\pi}|\mathcal{D}) = \mathsf{Dir}(\boldsymbol{\pi}|N_1 + \alpha_1, ..., N_C + \alpha_C)$$
$$p(\theta_{jc}|\mathcal{D}) = \mathsf{Beta}(\theta_{jc}|N_{jc} + \beta_1, (N_c - N_{jc}) + \beta_0)$$

• to compute the posterior we just updates the empirical counts of the likelihood with the prior counts

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• factored posterior

$$p(\theta|\mathcal{D}) = p(\pi|\mathcal{D}) \prod_{j=1}^{D} \prod_{c=1}^{C} p(\theta_{jc}|\mathcal{D})$$
$$p(\pi|\mathcal{D}) = \text{Dir}(\pi|N_1 + \alpha_1, ..., N_C + \alpha_C)$$
$$p(\theta_{jc}|\mathcal{D}) = \text{Beta}(\theta_{jc}|N_{jc} + \beta_1, (N_c - N_{jc}) + \beta_0)$$

• MAP estimate of
$$\boldsymbol{\pi} = [\pi_1, ..., \pi_C]$$

$$\hat{\pi} = \arg \max_{\pi} \operatorname{Dir}(\pi | N_1 + \alpha_1, ..., N_C + \alpha_C) \implies \hat{\pi}_c = \frac{N_c + \alpha_c - 1}{N + \alpha_0 - C}$$

• MAP estimate of θ_{jc} for $j \in \{1, ..., D\}$, $c \in \{1, ..., C\}$

$$\hat{\theta}_{jc} = \arg \max_{\theta_{jc}} \operatorname{Beta}(\theta_{jc} | N_{jc} + \beta_1, (N_c - N_{jc}) + \beta_0) \implies \hat{\theta}_{jc} = \frac{N_{jc} + \beta_1 - 1}{N_c + \beta_1 + \beta_0 - 2}$$

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Image: A matrix and a matrix

algorithm: MAP fitting a naive Bayes classifier to binary features (i.e. $\mathbf{x}_i \in \{0, 1\}^D$)

$$\begin{array}{l} N_c = 0, \; N_{jc} = 0 \; ; \\ \text{for } i = 1 : N \; \text{do} \\ \\ & \left| \begin{array}{c} c := y_i; \quad // \; \text{get the class label of the } i\text{-th sample} \\ N_c := N_c + 1; \\ \text{for } j = 1 : D \; \text{do} \\ & \left| \begin{array}{c} \text{if } \; x_{ij} = 1 \; \text{then} \\ & \left| \begin{array}{c} N_{jc} := N_{jc} + 1 \\ & \text{end} \end{array} \right| \\ \text{end} \\ \text{end} \end{array} \right|$$

$$\hat{\pi}_{c} = rac{N_{c}+lpha_{c}-1}{N+lpha_{0}-C}$$
, $\hat{ heta}_{jc} = rac{N_{jc}+eta_{1}-1}{N_{c}+eta_{1}+eta_{0}-2}$;

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• if we are given a new sample x the posterior predictive is

$$p(y = c | x, D) \propto p(x | y = c, D) p(y = c | D)$$

• with a NBC the class conditional density can factorized as

$$p(\mathbf{x}|\mathbf{y}=\mathbf{c},\mathcal{D}) = \prod_{j=1}^{D} p(\mathbf{x}_j|\mathbf{y}=\mathbf{c},\mathcal{D})$$

(since features are assumed to be conditionally independent given the class label)

• combining the two above equations returns

$$p(y = c | \mathbf{x}, D) \propto p(y = c | D) \prod_{j=1}^{D} p(x_j | y = c, D)$$

Naive Bayes Classifiers Posterior Predictive

we start from this factorization and we apply the Bayesian procedure

$$p(y = c | \mathbf{x}, \mathcal{D}) \propto p(y = c | \mathcal{D}) \prod_{j=1}^{D} p(x_j | y = c, \mathcal{D})$$

• first step, we integrate out the unknown π on the first factor

$$p(y=c|\mathcal{D}) = \int p(y=c,\pi|\mathcal{D})d\pi = \int p(y=c|\pi,\mathcal{D})p(\pi|\mathcal{D})d\pi =$$

 $\left(\pi \text{ gives enough information to compute } p(y=c)\right) = \int p(y=c|\pi)p(\pi|\mathcal{D})d\pi$

• second step, we integrate out the unknowns θ_{ic} on each remaining factor

$$p(x_j|y=c,\mathcal{D}) = \int p(x_j,\theta_{jc}|y=c,\mathcal{D})d\theta_{jc} = \int p(x_j|\theta_{jc},y=c,\mathcal{D})p(\theta_{jc}|y=c,\mathcal{D})d\theta_{jc}$$

$$ig($$
 the new $m{x}$ is independent from $\mathcal{D}ig) = \int p(x_j| heta_{jc},y=c)p(heta_{jc}|\mathcal{D})d heta_{jc}$

recollecting everything together returns

$$p(y = c | \mathbf{x}, \mathcal{D}) \propto \left[\int p(y = c | \pi) p(\pi | \mathcal{D}) d\pi
ight] \prod_{j=1}^{D} \left[\int p(x_j | \theta_{jc}, y = c) p(\theta_{jc} | \mathcal{D}) d\theta_{jc}
ight]$$

and plugging-in the model $\mathsf{PDFs}/\mathsf{PMFs}$ we adopted

$$p(y = c | \mathbf{x}, D) \propto \left[\int \mathsf{Cat}(y = c | \pi) \mathsf{Dir}(\pi | N_1 + \alpha_1, ..., N_C + \alpha_C) d\pi
ight] imes$$

$$\prod_{j=1}^{D} \left[\int \mathsf{Ber}(x_j | \theta_{jc}, y = c) \mathsf{Beta}(\theta_{jc} | \mathsf{N}_{jc} + \beta_1, (\mathsf{N}_c - \mathsf{N}_{jc}) + \beta_0) d\theta_{jc} \right] =$$

- the first part is a Dirichlet-multinomial model
- the second part is a product of beta-binomial models

doing the math again for the first part

$$\int \mathsf{Cat}(y = c | \pi) \mathsf{Dir}(\pi | N_1 + \alpha_1, ..., N_C + \alpha_C) d\pi =$$
$$\int \pi_c \, \mathsf{Dir}(\pi | N_1 + \alpha_1, ..., N_C + \alpha_C) d\pi = \mathbb{E}[\pi_c | \mathcal{D}] = \frac{N_c + \alpha_c}{N + \alpha_0}$$
where $\alpha_0 = \sum_c \alpha_c$

• this is exactly how we computed the **posterior mean** for the Dirichlet-multinomial model

$$\overline{\pi}_c = \mathbb{E}[\pi_c | \mathcal{D}] = \frac{N_c + \alpha_c}{N + \alpha_0}$$

Image: A matrix and a matrix

doing the math again for the second part

$$\int \mathsf{Ber}(x_j|\theta_{jc}, y = c)\mathsf{Beta}(\theta_{jc}|N_{jc} + \beta_1, (N_c - N_{jc}) + \beta_0)d\theta_{jc} =$$
$$= \int \theta_{jc}^{\mathbb{I}(x_j=1)} (1 - \theta_{jc})^{\mathbb{I}(x_j=0)} \mathsf{Beta}(\theta_{jc}|N_{jc} + \beta_1, (N_c - N_{jc}) + \beta_0)d\theta_{jc} =$$
$$= (\overline{\theta}_{jc})^{\mathbb{I}(x_j=1)} (1 - \overline{\theta}_{jc})^{\mathbb{I}(x_j=0)}$$

where

$$\overline{\theta}_{jc} = \mathbb{E}[\theta_{jc} | \mathcal{D}] = \frac{N_{jc} + \beta_1}{N_c + \beta_0 + \beta_1}$$

- in the above equations we first worked on $x_j = 1$ and then on $x_j = 0$
- this is exactly how we computed the **posterior mean** for the beta-binomial model

• the final posterior predictive is

$$p(y = c | \mathbf{x}, \mathcal{D}) \propto \overline{\pi}_c \prod_{j=1}^{D} (\overline{\theta}_{jc})^{\mathbb{I}(x_j=1)} (1 - \overline{\theta}_{jc})^{\mathbb{I}(x_j=0)}$$

with the posterior means

$$\overline{\theta}_{jc} = \mathbb{E}[\theta_{jc} | \mathcal{D}] = \frac{N_{jc} + \beta_1}{N_c + \beta_0 + \beta_1}$$

and

$$\overline{\pi}_c = \mathbb{E}[\pi_c | \mathcal{D}] = \frac{N_c + \alpha_c}{N + \alpha_0}$$

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- we can approximate the posterior with a single point, i.e. $p(\theta|D) \approx \delta_{\hat{\theta}}(\theta)$ where $\hat{\theta}$ can be the MAP or the MLE
- we obtain in this case a plug-in approximation

$$p(y=c|\mathbf{x},\mathcal{D}) \propto \hat{\pi}_c \prod_{j=1}^{D} (\hat{ heta}_{jc})^{\mathbb{I}(x_j=1)} (1-\hat{ heta}_{jc})^{\mathbb{I}(x_j=0)}$$

• the plug-in approximation is obviously more prone to overfitting

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Naive Bayes Classifiers Log-Sum-Exp Trick

• the posterior predictive has the following form

$$p(y = c | \mathbf{x}) = \frac{p(\mathbf{x} | y = c)p(y = c)}{p(\mathbf{x})} = \frac{p(\mathbf{x} | y = c)p(y = c)}{\sum_{c'} p(\mathbf{x} | y = c')p(y = c')}$$

- p(x|y = c) is often a very small number, especially if x is a high-dimensional vector, since we have to enforce ∑_{x'} p(x'|y = c) = 1
- this entails that a naive implementation of the posterior predictive can fail due to numerical underflow
- the obvious solution is to use logs

$$\log p(y=c|\mathbf{x}) = \log p(\mathbf{x}|y=c) + \log p(y=c) - \log p(\mathbf{x})$$

and if we define $b_c \triangleq \log p(\mathbf{x}|y=c) + \log p(y=c)$, one has

$$\log p(y=c|\mathbf{x}) = b_c - \log \left[\sum_{c'} e^{b_{c'}}\right]$$

• with
$$b_c \triangleq \log p(x|y=c) + \log p(y=c)$$
 we have

$$\log p(y = c | \mathbf{x}) = b_c - \log \left[\sum_{c'} e^{b_{c'}} \right]$$

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- now we have the problem that computing $e^{b_{c'}}$ can cause an overflow²
- we can use the log-sum-exp trick in order to avoid this problem

$$\log\left[\sum_{c} e^{b_{c}}\right] = \log\left[\left(\sum_{c} e^{b_{c}-B}\right)e^{B}\right] = \log\left[\sum_{c} e^{b_{c}-B}\right] + B$$

where $B \triangleq \max_{c} b_{c}$

• with this trick the biggest term $e^{b_c - B}$ equals zero

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²since $b_{c'}$ can be a big number

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Posterior Predictive Algorithm

the computed posterior predictive is

$$p(y = c | \mathbf{x}, \mathcal{D}) \propto \overline{\pi}_c \prod_{j=1}^{D} (\overline{\theta}_{jc})^{\mathbb{I}(x_j = 1)} (1 - \overline{\theta}_{jc})^{\mathbb{I}(x_j = 0)}$$

if we apply the log we obtain

$$\log p(y = c | \mathbf{x}, \mathcal{D}) \propto \log \overline{\pi}_c + \sum_{j=1}^{D} \mathbb{I}(x_j = 1) \log(\overline{\theta}_{jc}) + \mathbb{I}(x_j = 0) \log(1 - \overline{\theta}_{jc})$$

• the above log-posterior is the basis for the next algorithm

Naive Bayes Classifiers

Posterior Predictive Algorithm

algorithm: predicting with a naive Bayes classifier for binary features (i.e. $x_i \in \{0,1\}^D$)

for c = 1 : C do $\begin{array}{c}
L_c := \log \hat{\pi}_c; \\
\text{for } j = 1 : D \text{ do} \\
& | \quad \text{if } x_j = 1 \text{ then} \\
& | \quad L_c := L_c + \log \hat{\theta}_{jc} \\
& \text{else} \\
& | \quad L_c := L_c + \log(1 - \hat{\theta}_{jc}) \\
& \text{end} \\
& p_c := \exp(L_c - \log \operatorname{sumexp}(L_{1:C})); \quad // \text{ compute } p(y = c | \mathbf{x}, D) \\
\end{array}$ end $\hat{y} := \arg \max p_c;$

- the above algorithm computes $\hat{y} = \arg \max_{x} p(y = c | x, D)$
- the used parameter estimate θ̂ can be obviously best replaced with the posterior mean θ
 as shown in the computation of the full posterior predictive

Naive Bayes Classifiers

- Basic Concepts
- Class-Conditional Distributions
- Likelihood
- MLE
- Bayesian Naive Bayes
- Prior
- Posterior
- MAP
- Posterior Predictive
- Plug-in Approximation
- Log-Sum-Exp Trick
- Posterior Predictive Algorithm
- Feature Selection

- an NBC is commonly used to fit a joint distribution over potentially many features
- the NBC fitting algorithm is O(ND) where N is the dataset size and D is the size of x
- problems: D can be very high and NBC may suffer from overfitting
- a common approach to reduce these problems is to perform feature selection:
 - evaluate the relevance of each feature
 - accuracy-complexity)
 In the K most relevant features (K is chosen based on some tradeoff accuracy-complexity)

- correlation is a very limited measure of dependence; revise the slides about correlation and independence (lecture 3 part 2)
- a more general approach is to determine how similar is a joint distribution p(X, Y) to p(X)p(Y)
 (recall the definition X ⊥ Y)
- mutual information (MI)

$$\mathbb{I}[X;Y] \triangleq \mathbb{KL}[p(X,Y)||p(X)p(Y)] = \sum_{x} \sum_{y} p(x,y) \log \frac{p(x,y)}{p(x)p(y)}$$

• one has $\mathbb{I}[X; Y] \ge 0$ with equality iff p(X, Y) = p(X)p(Y)

• we want to measure the relevance between feature X_i and the class label Y

$$\mathbb{I}[X_j; Y] = \sum_{x_j} \sum_{y} p(x_j, y) \log \frac{p(x_j, y)}{p(x_j) p(y)}$$

• for an NBC classifier with binary features one has (homework ex 3.21)

$$I_j \triangleq \mathbb{I}[X_j; Y] = \sum_c \left[\theta_{jc} \pi_c \log \frac{\theta_{jc}}{\theta_j} + (1 - \theta_{jc}) \pi_c \log \frac{1 - \theta_{jc}}{1 - \theta_c} \right]$$

where the following quantities are computed by the NBC fitting algorithm: $\pi_c = p(y = c), \ \theta_{jc} = p(x_j = 1 | y = c) \text{ and } \theta_j = p(x_j = 1) = \sum_c \pi_c \theta_{jc}$

• the top K features with the highest I_j can then be selected and used

• Kevin Murphy's book

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